_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/519,891	YAMAMIZU ET AL.	
	Examiner	Art Unit	
	Megann E. Vaughn	2859	

SEARCHED							
Class	Subclass	Date	Examiner				
324	318	5/25/2006	MEV				

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
-						

(INCLUDING SEARCH	STRATEGY)
	DATE	EXMR
see attached EAST search history	5/25/2006	MEV
_		
	_	